

Ordering number : ENN7509

PNP Epitaxial Planar Silicon Transistor

**30A01C**

## Low-Frequency General-Purpose Amplifier Applications

### Applications

- Low-frequency power amplifier, muting circuit.

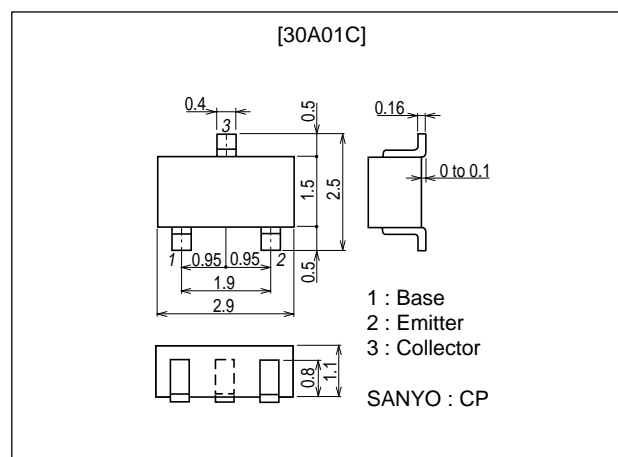
### Features

- Large current capacity.
- Low collector-to-emitter saturation voltage (resistance).  
 $R_{CE(sat)} \text{ typ} = 0.67\Omega [I_C = 0.3A, I_B = 15mA]$ .
- Ultrasmall package facilitates miniaturization in end products.
- Small ON-resistance ( $R_{on}$ ).

### Package Dimensions

unit : mm

2018B



### Specifications

#### Absolute Maximum Ratings at $T_a = 25^\circ\text{C}$

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	$V_{CB0}$		-30	V
Collector-to-Emitter Voltage	$V_{CEO}$		-30	V
Emitter-to-Base Voltage	$V_{EBO}$		-5	V
Collector Current	$I_C$		-300	mA
Collector Current (Pulse)	$I_{CP}$		-600	mA
Collector Dissipation	$P_C$	Mounted on a glass epoxy board (20X30X1.6mm).	300	mW
Junction Temperature	$T_J$		150	$^\circ\text{C}$
Storage Temperature	$T_{stg}$		-55 to +150	$^\circ\text{C}$

#### Electrical Characteristics at $T_a = 25^\circ\text{C}$

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector Cutoff Current	$I_{CB0}$	$V_{CB} = -30V, I_E = 0$			-0.1	$\mu\text{A}$
Emitter Cutoff Current	$I_{EBO}$	$V_{EB} = -4V, I_C = 0$			-0.1	$\mu\text{A}$
DC Current Gain	$h_{FE}$	$V_{CE} = -2V, I_C = -10mA$	200		500	
Gain-Bandwidth Product	$f_T$	$V_{CE} = -10V, I_C = -50mA$		520		MHz
Output Capacitance	$C_{ob}$	$V_{CB} = -10V, f = 1MHz$		3		pF
Collector-to-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100mA, I_B = -5mA$		-110	-220	mV
Base-to-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -100mA, I_B = -5mA$		-0.9	-1.2	V

Marking : XQ

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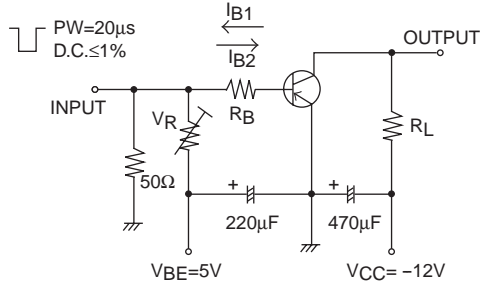
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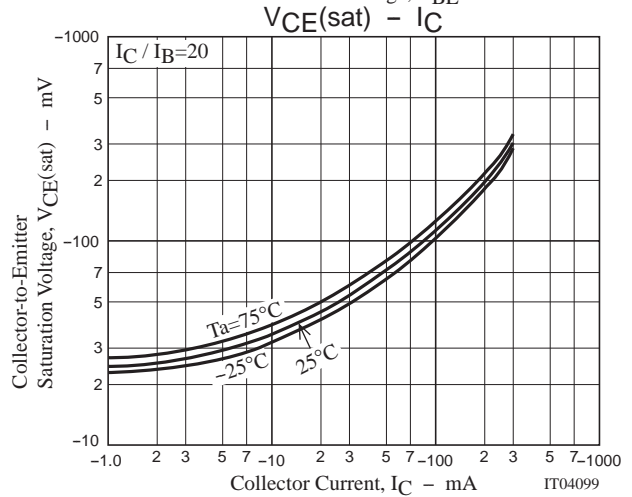
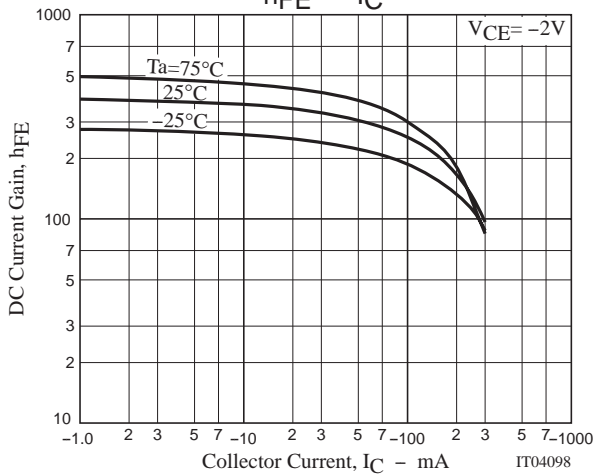
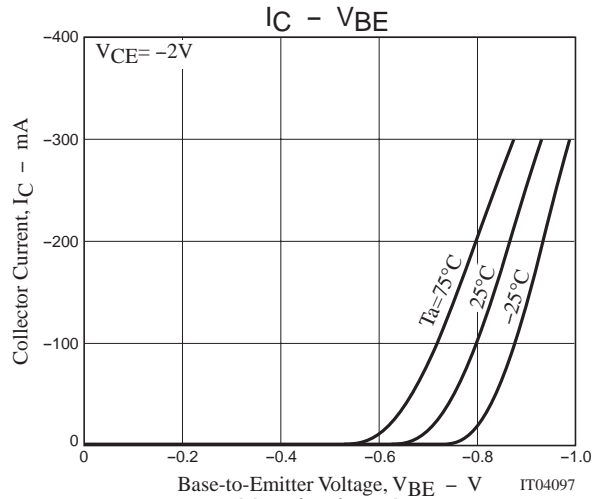
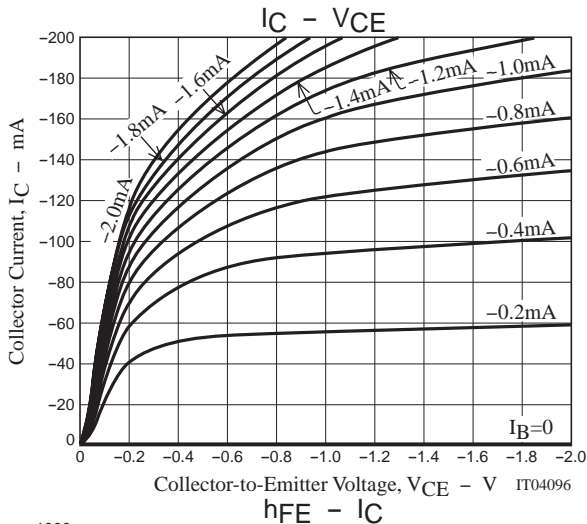
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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector-to-Base Breakdown Voltage	$V_{(BR)CBO}$	$I_C = -10\mu A, I_E = 0$	-30			V
Collector-to-Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C = -1mA, R_{BE} = \infty$	-30			V
Emitter-to-Base Breakdown Voltage	$V_{(BR)EBO}$	$I_E = -10\mu A, I_C = 0$	-5			V
Turn-ON Time	$t_{on}$	See specified Test Circuit.		39		ns
Storage Time	$t_{stg}$	See specified Test Circuit.		200		ns
Fall Time	$t_f$	See specified Test Circuit.		48		ns

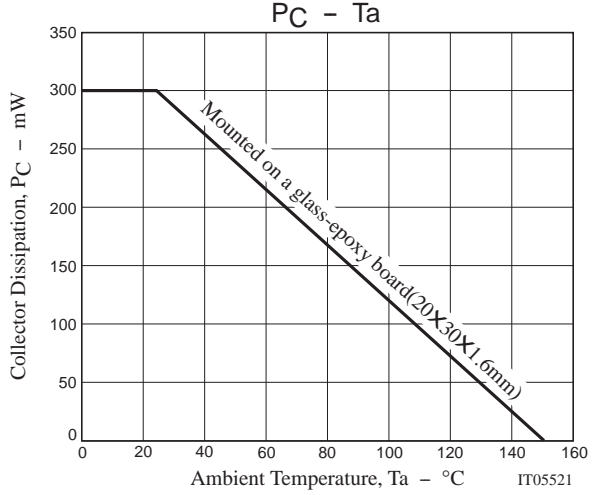
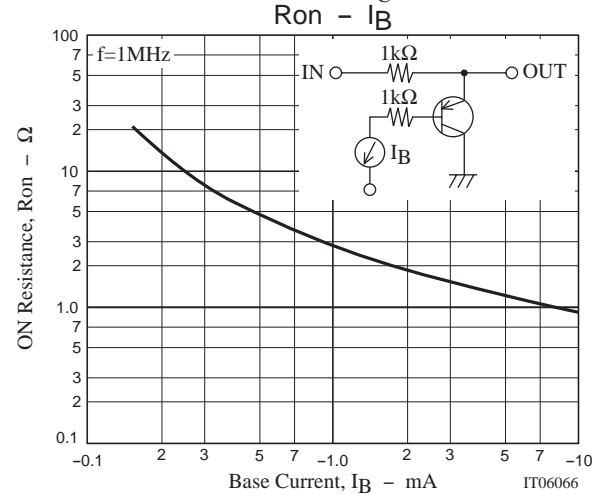
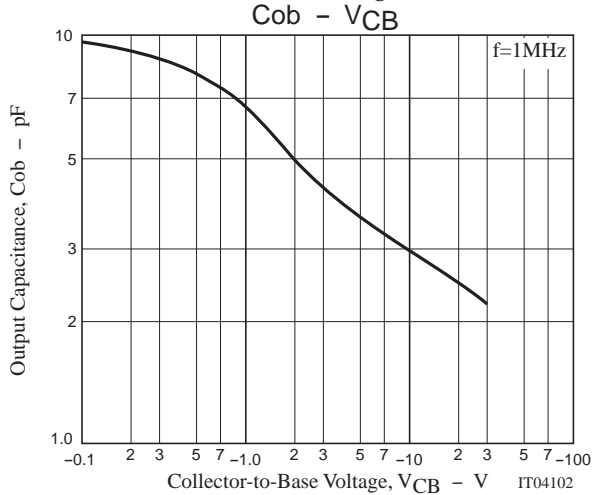
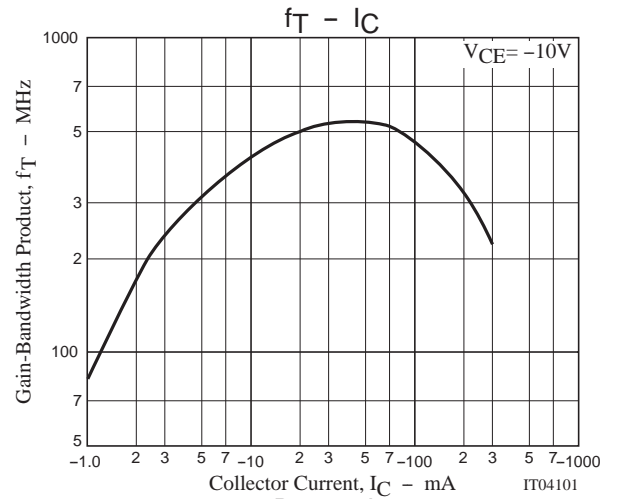
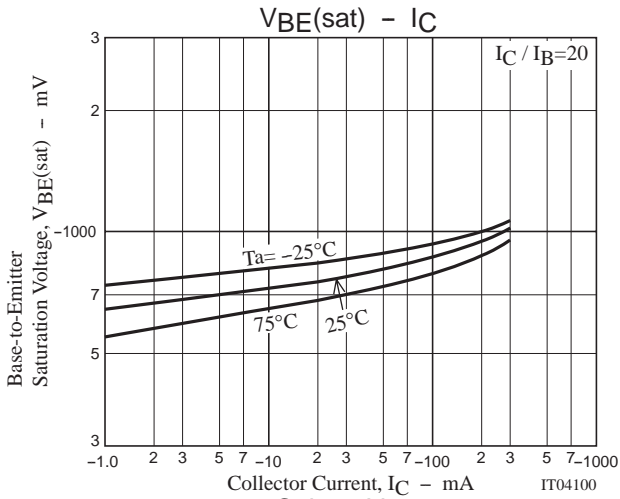
## Switching Time Test Circuit



$$I_C = 20I_{B1} = -20I_{B2} = -100mA$$



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